## INTEGRATED CIRCUITS



Product data

2002 May 21



Philips Semiconductors

## NE/SA/AU5232

### DESCRIPTION

The NE/SA/AU5232 is a matched, low voltage, high performance dual operational amplifier. Among its unique input and output characteristics is the capability for both input and output rail-to-rail operation, particularly critical in low voltage applications. The output swings to less than 50 mV of both rails across the entire power supply range. The NE/SA/AU5232 is capable of delivering 5.5 V peak-to-peak across a 600  $\Omega$  load and will typically draw only 700  $\mu$ A per amplifier. The bandwidth is 2.5 MHz and the 1% settling time is 1.4  $\mu$ s.

### FEATURES

- Wide common-mode input voltage range: 250 mV beyond both rails
- Output swing within 50 mV of both rails
- Functionality to 1.8 V typical
- Low current consumption: 700 μA per amplifier
- ±15 mA output current capability
- Unity gain bandwidth: 2.5 MHz
- Slew rate: 0.8 V/µs
- Low noise: 33 nV/√Hz
- Electrostatic discharge protection
- Short-circuit protection
- Output inversion prevention

#### **PIN CONFIGURATION**





### **APPLICATIONS**

- Automotive electronics
- Signal conditioning and sensing amplification
- Portable instrumentation
  - Test and measurement
  - Medical monitors and diagnostics
  - Remote meters
- Audio equipment
- Security systems
- Communications
  - Pagers
  - Cellular telephone
  - LAN
  - 5 V Datacom bus
- Error amplifier in motor drives
- Transducer buffer amplifier

### **ORDERING INFORMATION**

ORDER CODE	DESCRIPTION	TEMPERATURE RANGE	DWG #
NE5232D	8-Pin Plastic Small Outline (SO) package	0 °C to +70 °C	SOT96-1
NE5232N	8-Pin Plastic Dual In-Line Package (DIP)	0 °C to +70 °C	SOT97-1
SA5232D	8-Pin Plastic Small Outline (SO) package	–40 °C to +85 °C	SOT96-1
SA5232N	8-Pin Plastic Dual In-Line Package (DIP)	–40 °C to +85 °C	SOT97-1
AU5232N	8-Pin Plastic Dual In-Line Package (DIP)	–40 °C to +125 °C	SOT97-1
AU5232D	8-Pin Plastic Small Outline (SO) package	–40 °C to +125 °C	SOT96-1

## NE/SA/AU5232

### **ABSOLUTE MAXIMUM RATINGS**

SYMBOL	PARAMETER	RATING	UNIT
V <sub>CC</sub>	Single supply voltage	7	V
V <sub>ESD</sub>	ESD protection voltage at any pin <sup>5</sup> human body model robot model	2000 200	V V
Vs	Dual supply voltage	±3.5	V
V <sub>DP</sub>	Voltage at any device pin <sup>1</sup>	$V_{S} \pm 0.5$	V
I <sub>DP</sub>	Current into any device pin <sup>1</sup>	±50	mA
V <sub>i(dif)</sub>	Differential input voltage <sup>2</sup>	0.5	V
V <sub>i(CM)</sub>	Common-mode input voltage (positive)	V <sub>CC</sub> + 0.5	V
V <sub>i(CM)</sub>	Common-mode input voltage (negative)	V <sub>EE</sub> - 0.5	V
PD	Power dissipation <sup>3</sup>	500	mW
Тj	Operating junction temperature <sup>3</sup>	+150	°C
V <sub>SC</sub>	Supply voltage allowing indefinite output short circuit to either rail <sup>3,4</sup>	7	V
T <sub>stg</sub>	Storage temperature range	-65 to +150	°C
T <sub>sld</sub>	Lead soldering temperature (10 sec max)	+230	°C
$\theta_{JA}$	Thermal impedance 8-pin plastic DIP 8-pin plastic SO		°C/W °C/W

NOTES:

 Each pin is protected by ESD diodes. The voltage at any pin is limited by the ESD diodes.
The differential input of each amplifier is limited by two internal diodes, connected in parallel and opposite to each other. For more differential input range, use differential resistors in series with the input pins. The maximum operating junction temperature is +150 °C. At elevated temperatures, devices must be derated according to the package

3. thermal resistance and device mounting conditions. Derates above +25 °C: N package at 9.5 mW/°C; D package at 6.25 mW/°C.

Simultaneous short circuits of two amplifiers to the positive or negative rail can exceed the power dissipation ratings and cause eventual 4. destruction of the device.

5. Guaranteed by design.

### **RECOMMENDED OPERATING CONDITIONS**

SYMBOL	PARAMETER	RATING	UNIT
V <sub>CC</sub>	Single supply voltage	+2 to +5.5	V
Vs	Dual supply voltage	±1 to ±2.75	V
V <sub>i(CM)</sub>	Common-mode input voltage (positive)	V <sub>CC</sub> + 0.25	V
V <sub>i(CM)</sub>	Common-mode input voltage (negative)	V <sub>EE</sub> – 0.25	V
T <sub>amb</sub>	Temperature NE SA AU	0 to +70 -40 to +85 -40 to +125	ο° ο°

### DC ELECTRICAL CHARACTERISTICS

 $V_{CC}$  = 2 V to 5.5 V,  $V_{EE}$  = 0 V,  $T_{amb}$  = 25 °C;  $V_{EE}$  <  $V_{i(CM)}$  <  $V_{CC}$ ; unless otherwise stated.

		TEST CONDITIONS	LIMITS							
SYMBOL	PARAMETER	TEST CONDITIONS	NE5232					SA5232		
			MIN	TYP MAX		MIN	TYP	MAX	]	
		$V_{CC} = 5.5V$		1.4	2.0		1.4	2.0		
ICC	Supply current	V <sub>CC</sub> = 5.5 V; over full temp. range		1.5	2.3		1.6	2.4	mA	
	Official and the sec			±0.2	±4		±0.2	±4		
V <sub>OS</sub>	Offset voltage	Over full temp. range		±0.4	±5		±0.6	±5	mV	
$\Delta V_{OS} / \Delta T$	Offset voltage drift with temperature			4			4		μV/°0	
ΔV <sub>OS</sub>	Offset voltage difference between any amplifiers in			0.4	3		0.4	3	mV	
2105	the same package at the same common mode level <sup>1</sup>	Over full temp. range		0.8	4		1.2	4		
los	Offset current			±3	±20		±3	±30	nA	
.00		Over full temp. range		±4	±30		±6	±60		
$\Delta I_{OS} / \Delta T$	Offset current drift with temperature			0.02	±.3		0.03	±.3	nA/°(	
		$V_{EE} < V_{i(CM)} < V_{EE}$ +0.5 V	-200	-90		-200	-90			
IB	Input bias current <sup>1</sup>	Over full temp. range	-225	-100		-250	-150		nA	
чВ	input bias current	$V_{EE}$ +1 V < $V_{i(CM)}$ < $V_{CC}$		25	70		25	75		
		Over full temp. range		35	100		35	120		
$\Delta I_{\rm B} / \Delta T$	Input bias current drift with temperature			0.5			0.5		nA/°	
	$\Delta I_{B}$ Input bias current difference between any amplifier in the same	$V_{EE} < V_{i(CM)} < V_{EE}$ +0.5 V		10	30		10	30		
$\Delta I_B$		Over full temp. range		25	50		50	70	nA	
	package at the same	$V_{EE}$ +1 V < $V_{i(CM)}$ < $V_{CC}$		5	20		5	20	] "~	
	common mode level.	Over full temp. range		15	30		25	50		
		$V_{OS} \le 6 \text{ mV}$	V <sub>EE</sub> -0.25		V <sub>CC</sub> +0.25	V <sub>EE</sub> -0.25		V <sub>CC</sub> +0.25		
V <sub>i(CM)</sub>	Common-mode input range	V <sub>OS</sub> ≤ 6 mV; Over full temp. range	V <sub>EE</sub> -0.1		V <sub>CC</sub> +0.1	V <sub>EE</sub> -0.1		V <sub>CC</sub> +0.1		
	Common-mode rejection ratio, small signal	$\label{eq:VEE} \begin{array}{l} V_{\text{EE}} < V_{i(\text{CM})} < V_{\text{EE}} + 0.5 \text{V}; \\ V_{\text{EE}} + 1 \text{V} < V_{i(\text{CM})} < V_{\text{CC}} \end{array}$	80	100		80	100			
CMRR	Tallo, Small Signal	Over full temp. range	75	100		75			dB	
	Common-mode rejection	$V_{EE} < V_{i(CM)} < V_{CC}$	65	90		65	90		]	
	ratio, large signal	Over full temp. range	60	80		60			]	
PSRR	Power supply rejection	$V_{EE} < V_{i(CM)} < V_{CC}$	80	100		80	100		dB	
1 OKK	ratio	Over full temp. range	80	90		80	90			
۱L	Peak load current, sink and		10	12		10	12		mA	
ιĽ	source	Over full temp. range	5	8		5	8			
A <sub>VOL</sub>	Open-loop voltage gain		90	110		90	110		dB	
' 'VOL	opon loop voltage gain	Over full temp. range		90			90			
		I <sub>PEAK</sub> = 0.1 mA	V <sub>EE</sub> +0.05		V <sub>CC</sub> -0.05	V <sub>EE</sub> +0.1		V <sub>CC</sub> -0.1		
	Output voltage swing	I <sub>PEAK</sub> = 10 mA	V <sub>EE</sub> +0.25		V <sub>CC</sub> -0.25	V <sub>EE</sub> +0.25		V <sub>CC</sub> -0.25	v	
V <sub>OUT</sub>		I <sub>PEAK</sub> = 5 mA; over full temp. range	V <sub>EE</sub> +0.22		V <sub>CC</sub> -0.22	V <sub>EE</sub> +0.2		V <sub>CC</sub> -0.2	- V	
	Output voltage swing for	$R_L = 2 k\Omega$	V <sub>EE</sub> +0.2		V <sub>CC</sub> -0.2	V <sub>EE</sub> +0.2		V <sub>CC</sub> -0.2	v	
	$V_{CC} = 2.75 \text{ V}, V_{EE} = -2.75 \text{ V}$	R <sub>L</sub> = 600 Ω	V <sub>EE</sub> +0.25		V <sub>CC</sub> -0.25	V <sub>EE</sub> +0.25		V <sub>CC</sub> -0.25	ľ	

NOTE:

These parameters are measured for V<sub>EE</sub> < V<sub>CM</sub> < V<sub>EE</sub>+0.5 V and for V<sub>EE</sub>+1 V < V<sub>CM</sub> < V<sub>CC</sub>. By design these parameters are intermediate for common mode ranges between the measured regions.

## NE/SA/AU5232

### DC ELECTRICAL CHARACTERISTICS

 $V_{CC}$  = 2 V to 5.5 V,  $V_{EE}$  = 0 V,  $T_{amb}$  = 25 °C;  $V_{EE}$  <  $V_{i(CM)}$  <  $V_{CC}$ ; unless otherwise stated.

		TEST CONDITIONS		4			
SYMBOL	PARAMETER	TEST CONDITIONS		AU5232	2		
			MIN	TYP	MAX		
		$V_{CC} = 5.5V$		1.4	2.0		
I <sub>CC</sub>	Supply current	V <sub>CC</sub> = 5.5 V; over full temp. range		1.6	2.4	mA	
V	Offect veltage			±0.2	±4	m\/	
V <sub>OS</sub>	Offset voltage	Over full temp. range		±0.6	±5	mV	
$\Delta V_{OS} / \Delta T$	Offset voltage drift with temperature			4		μV/°C	
A \ (	Offset voltage difference between any amplifiers in the			0.4	3		
$\Delta V_{OS}$	same package at the same common mode level <sup>1</sup>	Over full temp. range		1.2	4	mV	
	0			±3	±30		
IOS	Offset current	Over full temp. range		±6	±60	nA	
$\Delta I_{OS} / \Delta T$	Offset current drift with temperature			0.03	±.3	nA/°C	
		$V_{EE} < V_{i(CM)} < V_{EE}$ +0.5 V	-200	-90			
		Over full temp. range	-250	-150		nA	
IВ	Input bias current <sup>1</sup>	$V_{EE}$ +1 V < $V_{i(CM)}$ < $V_{CC}$		25	75		
		Over full temp. range		35	120	1	
$\Delta I_{B} / \Delta T$	Input bias current drift with temperature			0.5		nA/°C	
0		V <sub>EE</sub> < V <sub>i(CM)</sub> < V <sub>EE</sub> +0.5 V		10	30		
$\Delta I_B$	Input bias current difference between any amplifier in the	Over full temp. range		50	70	1	
D	same package at the same common mode level.	$V_{EE}$ +1 V < $V_{i(CM)}$ < $V_{CC}$		5	20	nA	
		Over full temp. range		25	50		
		$V_{OS} \le 6 \text{ mV}$	V <sub>EE</sub> -0.25		V <sub>CC</sub> +0.25		
V <sub>i(CM)</sub>	Common-mode input range	$V_{OS} \le 6 \text{ mV};$ Over full temp. range	V <sub>EE</sub> -0.1		V <sub>CC</sub> +0.1	V	
	Common-mode rejection ratio, small signal	V <sub>EE</sub> < V <sub>i(CM)</sub> < V <sub>EE</sub> +0.5V; V <sub>EE</sub> +1V < V <sub>i(CM)</sub> < V <sub>CC</sub>	80	100			
CMRR		Over full temp. range	70			dB	
		$V_{EE} < V_{i(CM)} < V_{CC}$	65	90		1	
	Common-mode rejection ratio, large signal	Over full temp. range	55			1	
DODD	Deven even handle effect with	$V_{EE} < V_{i(CM)} < V_{CC}$	80	100			
PSRR	Power supply rejection ratio	Over full temp. range	75	90		dB	
	Deale land summation is to a discussion		10	12			
۱L	Peak load current, sink and source	Over full temp. range	5	8		mA	
٨			90	110			
A <sub>VOL</sub>	Open-loop voltage gain	Over full temp. range		90		dB	
		I <sub>PEAK</sub> = 0.1 mA	V <sub>EE</sub> +0.1		V <sub>CC</sub> -0.1		
	Output voltage swing	I <sub>PEAK</sub> = 10 mA	V <sub>EE</sub> +0.25		V <sub>CC</sub> -0.25	- I	
V <sub>OUT</sub>	Output voltage swillig	I <sub>PEAK</sub> = 5 mA; over full temp. range	V <sub>EE</sub> +0.2		V <sub>CC</sub> -0.2		
	Output voltage swing for	$R_L = 2 k\Omega$	V <sub>EE</sub> +0.2		V <sub>CC</sub> -0.2		
	$V_{CC} = 2.75 \text{ V}, V_{EE} = -2.75 \text{ V}$	R <sub>L</sub> = 600 Ω	V <sub>EE</sub> +0.25		V <sub>CC</sub> -0.25	V	

NOTE:
1. These parameters are measured for V<sub>EE</sub> < V<sub>CM</sub> < V<sub>EE</sub>+0.5 V and for V<sub>EE</sub>+1 V < V<sub>CM</sub> < V<sub>CC</sub>. By design these parameters are intermediate for common mode ranges between the measured regions.

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## Product data

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### AC ELECTRICAL CHARACTERISTICS

 $T_{amb}$  = +25 °C; V\_{CC} = 2 V to 5.5 V; R<sub>L</sub> = 10 kΩ; C<sub>L</sub> = 100 pF; unless otherwise stated.

SYMBOL	PARAMETER	TEST CONDITIONS		NE5232		S	2	UNIT	
			MIN	TYP	MAX	MIN	TYP	MAX	
SR	Slew rate	Over full temperature range	0.5	0.8		0.5	0.8		V/µs
BW	Unity gain bandwidth: –3 dB	Over full temperature range	2	2.5	4.0	2	2.5	4.0	MHz
θΜ	Phase Margin	C <sub>L</sub> = 50 pF		55			55		deg
t <sub>S</sub>	1% settling time	$A_V = 1, 1 V \text{ step}$		1.4			1.4		μs
V <sub>N</sub>	Input referred voltage noise	$A_V = 1$ , $R_S = 0 \Omega$ , at 1 kHz		33			33		nV/Hz <sup>1/2</sup>
THD	Total harmonic distortion	10 kHz, 1V <sub>P-P</sub> , A <sub>V</sub> = 1		0.1			0.1		%

### **OUTPUT INVERSION PREVENTION**



Figure 2. Output inversion prevention.

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Product data





Product data

1.15

0.045



UNIT	max.	min.	max.	D	D <sub>1</sub>	D <sub>2</sub>	c	D	E	e	e <sub>1</sub>	L	ME	МН	w	
mm	4.2	0.51	3.2	1.73 1.14	0.53 0.38	1.07 0.89	0.36 0.23	9.8 9.2	6.48 6.20	2.54	7.62	3.60 3.05	8.25 7.80	10.0 8.3	0.254	
inches	0.17	0.020	0.13	0.068 0.045	0.021 0.015	0.042 0.035	0.014 0.009	0.39 0.36	0.26 0.24	0.10	0.30	0.14 0.12	0.32 0.31	0.39 0.33	0.01	

#### Note

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1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	EUROPEAN ISSUE DATE			
VERSION	IEC	JEDEC	EIAJ	PROJECTION	ISSUE DATE	
SOT97-1	050G01	MO-001	SC-504-8		<del>-95-02-04</del> 99-12-27	

## NE/SA/AU5232

NOTES

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#### Data sheet status

Data sheet status <sup>[1]</sup>	Product status <sup>[2]</sup>	Definitions
Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
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